

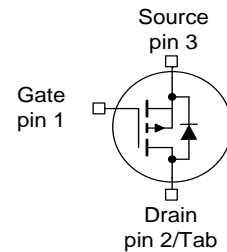
OptiMOS[®]-P2 Power-Transistor

Features

- P-channel - Logic Level - Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (RoHS compliant)
- 100% Avalanche tested

Product Summary

V_{DS}	-40	V
$R_{DS(on)}$	7.8	m Ω
I_D	-70	A

PG-TO252-3-313


Type	Package	Marking
IPD70P04P4L-08	PG-TO252-3-313	4P04L08

Maximum ratings, at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_C=25^\circ\text{C}$, $V_{GS}=-10\text{V}$	-70	A
		$T_C=100^\circ\text{C}$, $V_{GS}=-10\text{V}^{1)}$	-55	
Pulsed drain current ¹⁾	$I_{D,pulse}$	$T_C=25^\circ\text{C}$	-280	
Avalanche energy, single pulse ¹⁾	E_{AS}	$I_D=-35\text{A}$	24	mJ
Avalanche current, single pulse	I_{AS}	-	-70	A
Gate source voltage	V_{GS}	-	+5/-16	V
Power dissipation	P_{tot}	$T_C=25^\circ\text{C}$	75	W
Operating and storage temperature	T_j, T_{stg}	-	-55 ... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics¹⁾						
Thermal resistance, junction - case	R_{thJC}	-	-	-	2.0	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ²⁾	-	-	40	

Electrical characteristics, at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-1mA$	-40	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-120\mu A$	-1.2	-1.7	-2.2	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=-32V, V_{GS}=0V, T_j=25^\circ\text{C}$	-	-0.05	-1	μA
		$V_{DS}=-32V, V_{GS}=0V, T_j=125^\circ\text{C}^{1)}$	-	-20	-200	
Gate-source leakage current	I_{GSS}	$V_{GS}=-16V, V_{DS}=0V$	-	-	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=-4.5V, I_D=-40A$	-	9.5	12.9	m Ω
		$V_{GS}=-10V, I_D=-70A$	-	6.4	7.8	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics¹⁾

Input capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=-25V,$ $f=1MHz$	-	4177	5430	pF
Output capacitance	C_{oss}		-	1185	1778	
Reverse transfer capacitance	C_{rss}		-	45	90	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=-20V,$ $V_{GS}=-10V, I_D=-70A,$ $R_{G,ext}=3.5\Omega$	-	12	-	ns
Rise time	t_r		-	10	-	
Turn-off delay time	$t_{d(off)}$		-	50	-	
Fall time	t_f		-	41	-	

Gate Charge Characteristics¹⁾

Gate to source charge	Q_{gs}	$V_{DD}=-32V, I_D=-70A,$ $V_{GS}=0$ to $-10V$	-	14	18	nC
Gate to drain charge	Q_{gd}		-	10	20	
Gate charge total	Q_g		-	71	92	
Gate plateau voltage	$V_{plateau}$		-	-3.5	-	V

Reverse Diode

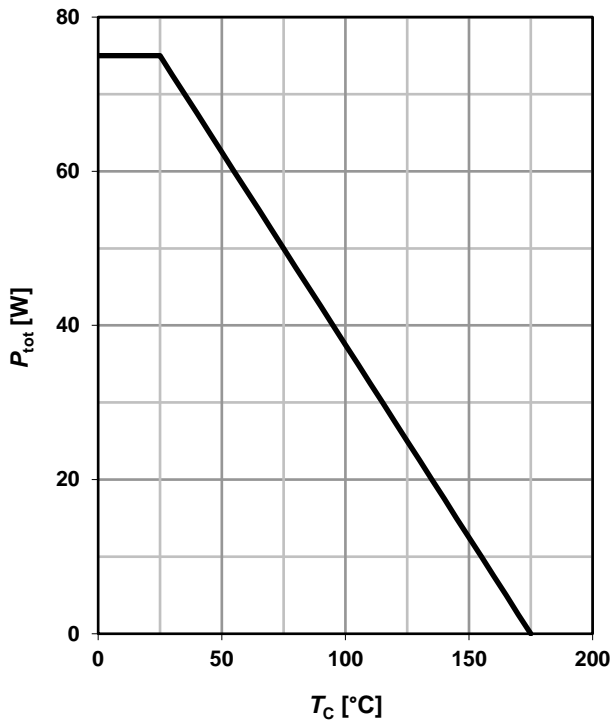
Diode continuous forward current ¹⁾	I_S	$T_C=25^\circ C$	-	-	-70	A
Diode pulse current ¹⁾	$I_{S,pulse}$		-	-	-280	
Diode forward voltage	V_{SD}	$V_{GS}=0V, I_F=-70A,$ $T_j=25^\circ C$	-	-1	-1.3	V
Reverse recovery time ¹⁾	t_{rr}	$V_R=-20V, I_F=-50A,$ $di_F/dt=-100A/\mu s$	-	46	-	ns
Reverse recovery charge ¹⁾	Q_{rr}		-	43	-	nC

¹⁾ Defined by design. Not subject to production test.

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

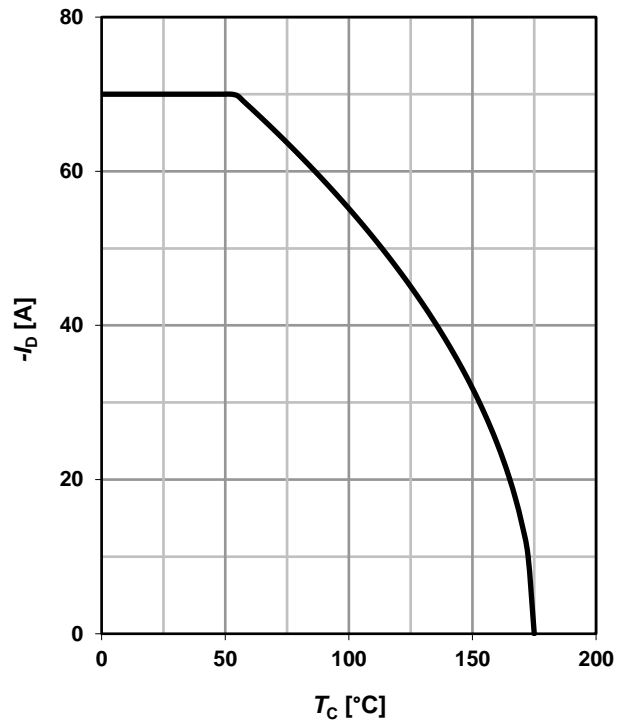
1 Power dissipation

$P_{tot} = f(T_C); V_{GS} \leq -6V$



2 Drain current

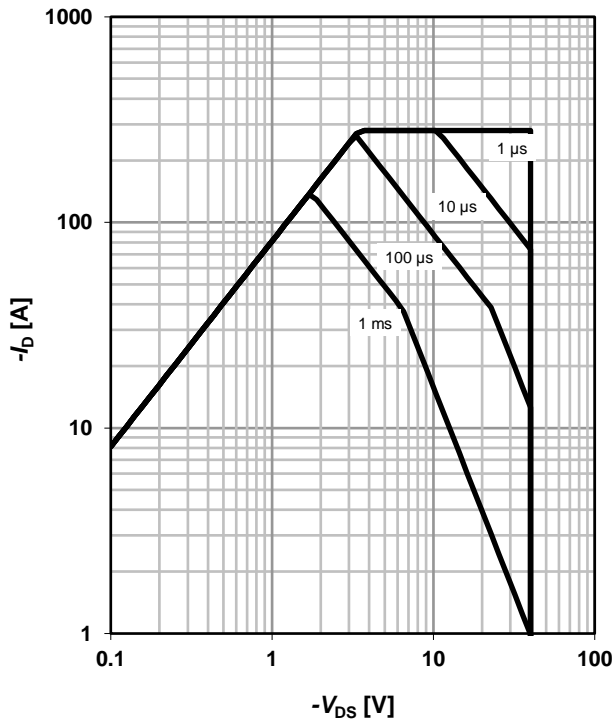
$I_D = f(T_C); V_{GS} = -10V$



3 Safe operating area

$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

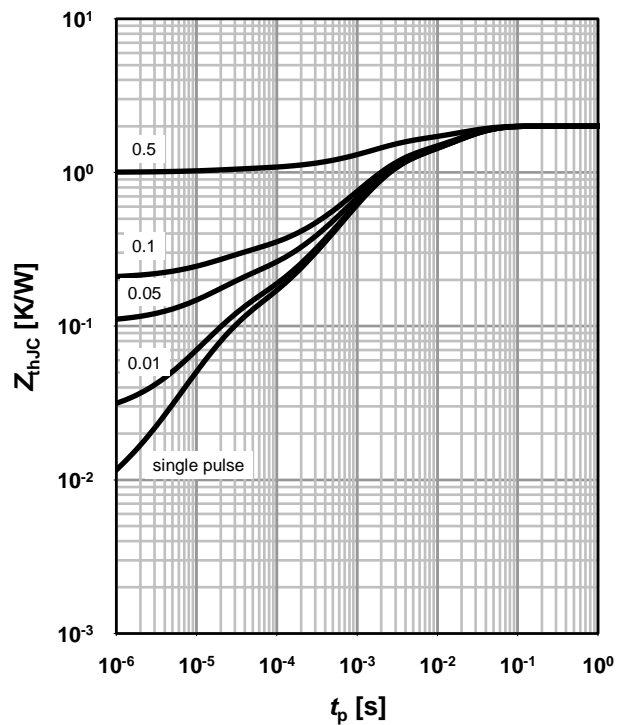
parameter: t_p



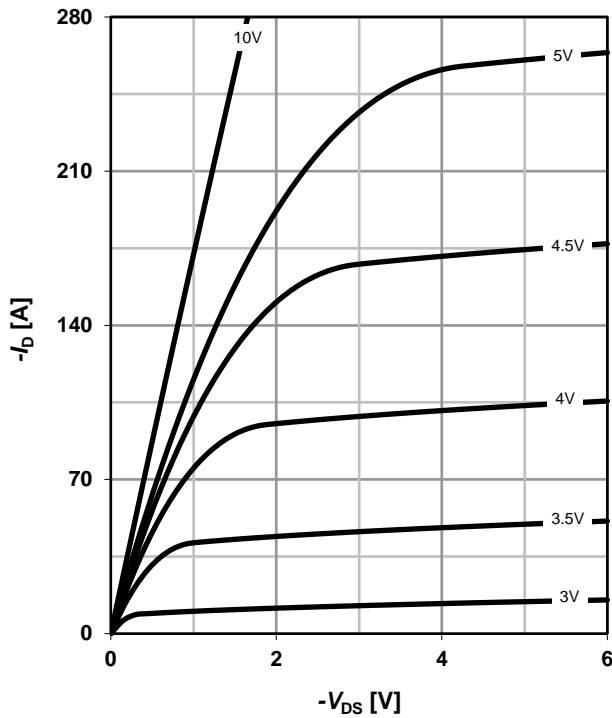
4 Max. transient thermal impedance

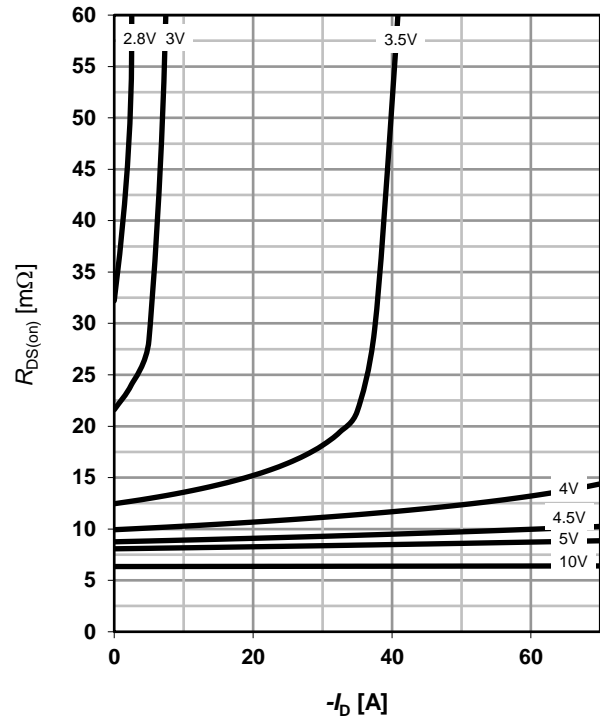
$Z_{thJC} = f(t_p)$

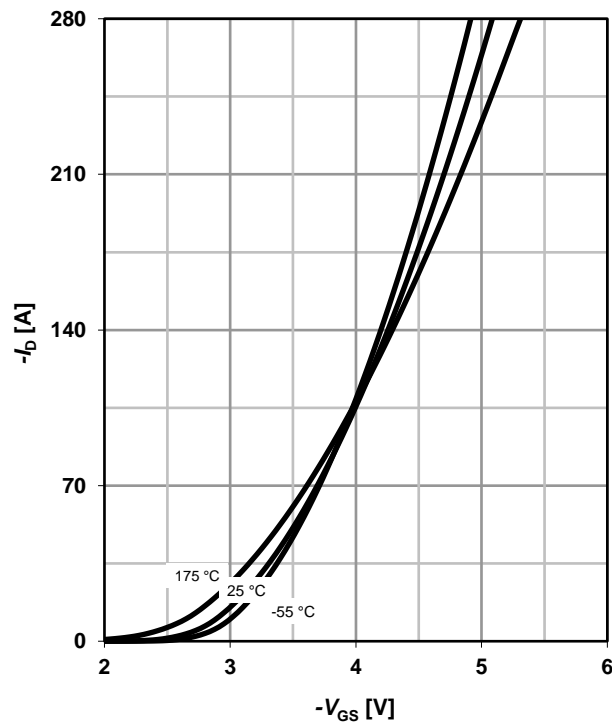
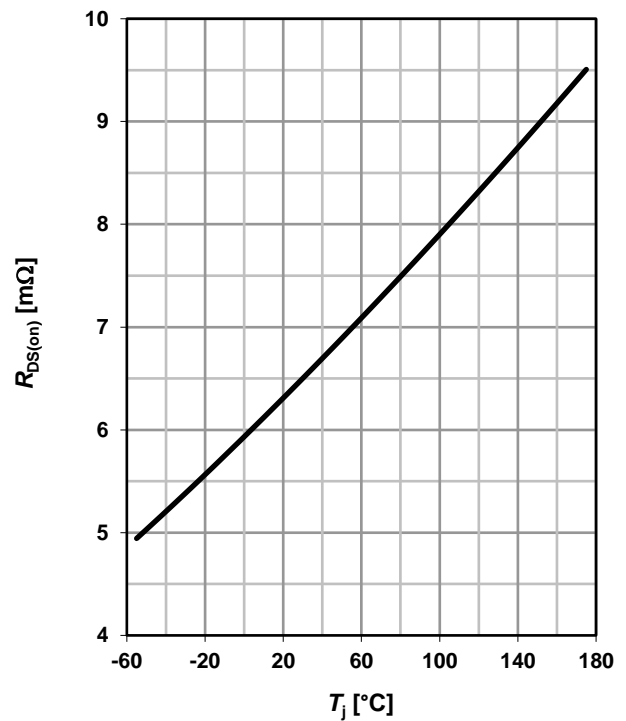
parameter: $D = t_p/T$



5 Typ. output characteristics
 $I_D = f(V_{DS}); T_j = 25\text{ °C}$

 parameter: $-V_{GS}$

6 Typ. drain-source on-state resistance
 $R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$

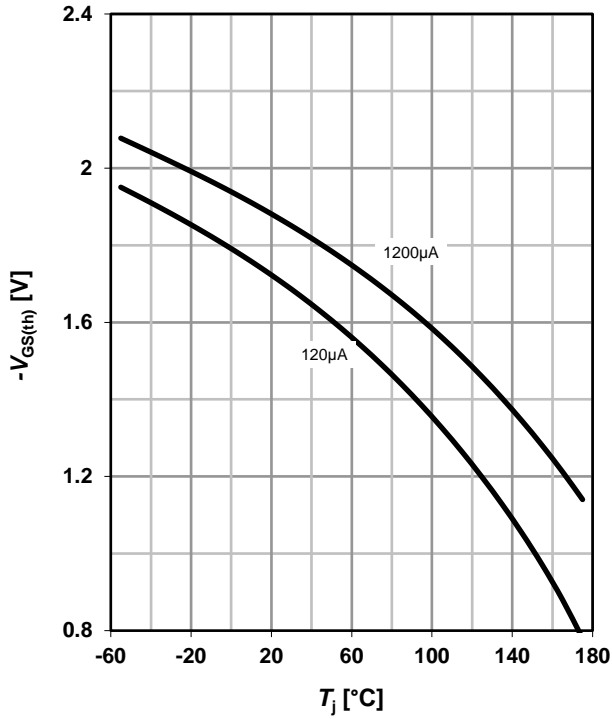
 parameter: $-V_{GS}$

7 Typ. transfer characteristics
 $I_D = f(V_{GS}); V_{DS} = -6V$

 parameter: T_j

8 Typ. drain-source on-state resistance
 $R_{DS(on)} = f(T_j); I_D = -70\text{ A}; V_{GS} = -10\text{ V}$


9 Typ. gate threshold voltage

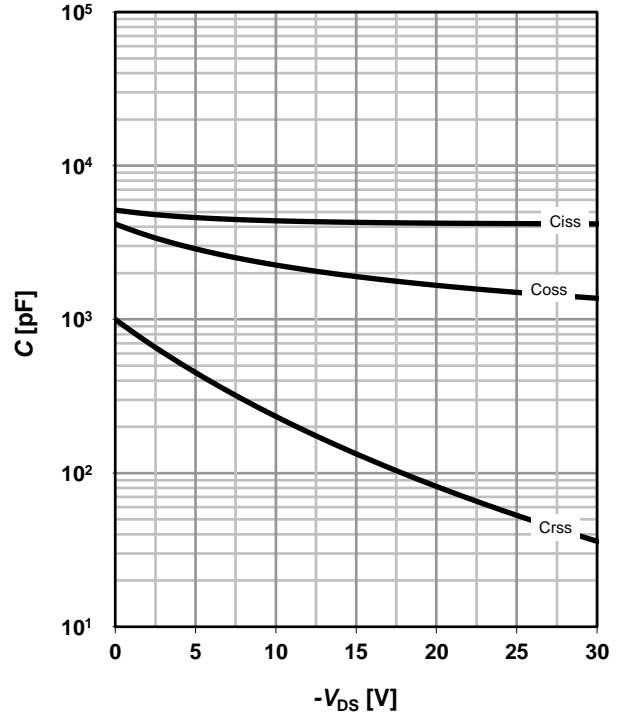
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: $-I_D$



10 Typ. capacitances

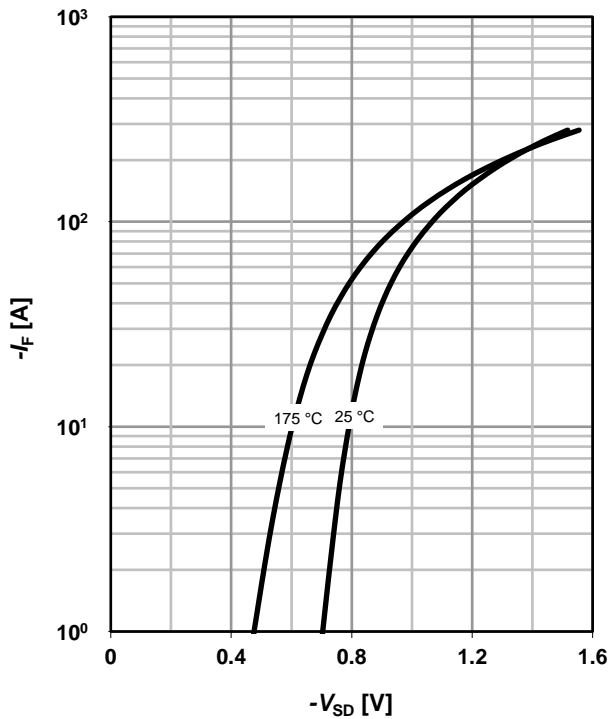
$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



11 Typical forward diode characteristics

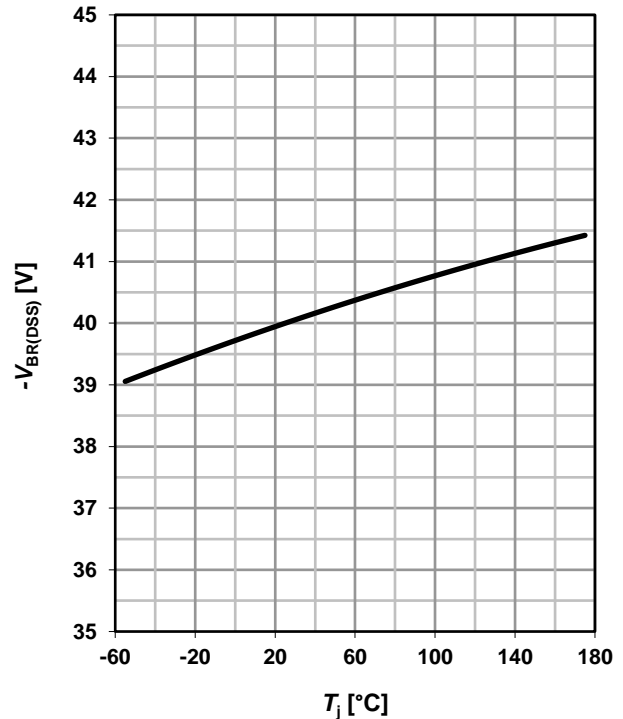
$I_F = f(V_{SD})$

parameter: T_j



12 Drain-source breakdown voltage

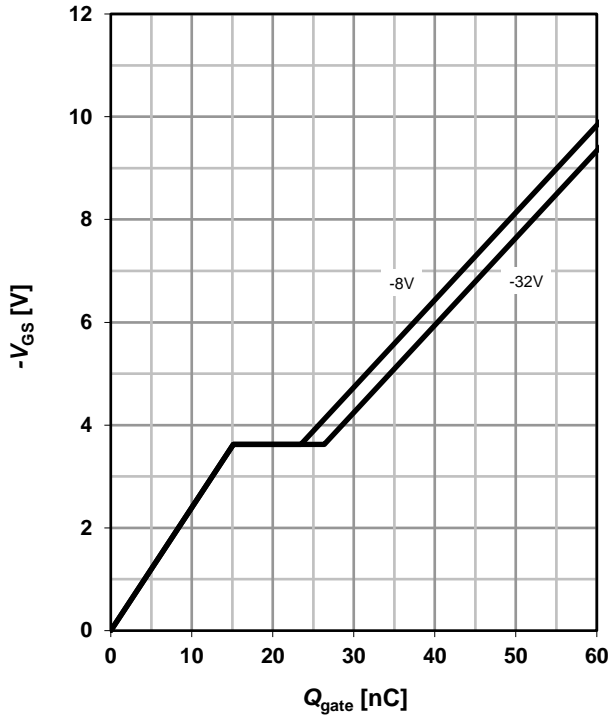
$V_{BR(DSS)} = f(T_j); I_D = -1 mA$



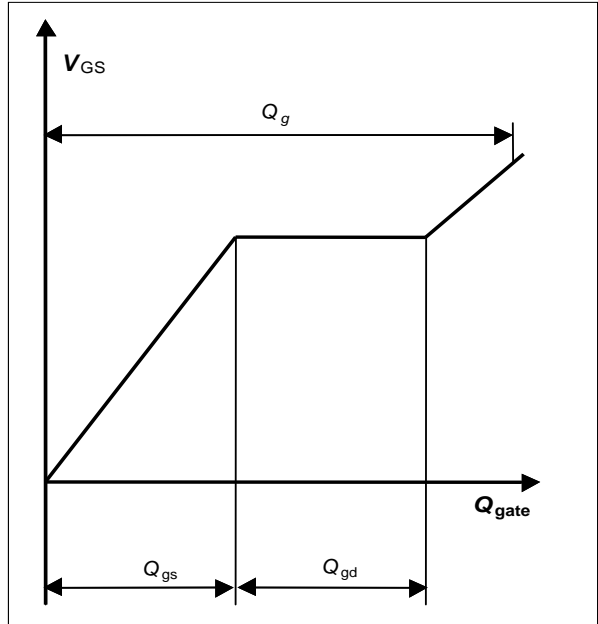
13 Typ. gate charge

$V_{GS} = f(Q_{gate}); I_D = -70\text{ A pulsed}$

parameter: V_{DD}



14 Gate charge waveforms



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Revision History

Version	Date	Changes
1.0	14.03.2011	Final Data Sheet
1.1	21.12.2012	Update of typical Rdson
1.2	04.07.2019	V _{GS} changed
1.21	19.08.2021	Editorial changes